

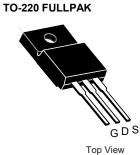
K30A06N1-VB Datasheet N-Channel 60-V (D-S) MOSFET

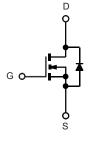
| PRODUCT | SUMMARY | |
|---------------------|----------------------------------|---------------------------------|
| V _{DS} (V) | R_{DS(on)} (Ω) | I _D (A) ^a |
| 60 | 0.010 at V _{GS} = 10 V | 70 |
| 00 | 0.012 at V _{GS} = 4.5 V | 55 |

FEATURES

- 175 °C Junction Temperature
- TrenchFET[®] Power MOSFET
- Material categorization:







N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C = 25 | °C, unless other | wise noted) | | |
|---|-------------------------|-----------------------------------|--------------------------------------|------|
| Parameter | | Symbol | Limit | Unit |
| Gate-Source Voltage | | V _{GS} | ± 20 | V |
| Continuous Ducia Current (T. $= 475^{\circ}$ Colt | T _C = 25 °C | 1- | 70 | |
| Continuous Drain Current (T _J = 175 °C) ^b | T _C = 100 °C | | 50ª | |
| Pulsed Drain Current | | I _{DM} | 200 | A |
| Continuous Source Current (Diode Conduction) | | I _S | 50ª | |
| Avalanche Current | | I _{AS} | 50 | - |
| Single Avalanche Energy (Duty Cycle \leq 1 %) | L = 0.1 mH | E _{AS} | 125 | mJ |
| Maximum Power Dissipation | T _C = 25 °C | - P _D - | 136 | w |
| | T _A = 25 °C | | 3 ^b , 8.3 ^{b, c} | |
| Operating Junction and Storage Temperature Range | · | T _J , T _{stg} | - 55 to 175 | °C |

| THERMAL RESISTANCE RATINGS | | | | | |
|--|------------------------|-------------------|---------|---------|------|
| Parameter | | Symbol | Typical | Maximum | Unit |
| Marvinson long ting to Angleis at | $t \le 10 \text{ sec}$ | R _{thJA} | 15 | 18 | |
| Maximum Junction-to-Ambient ^a | Steady State | h thJA | 40 | 50 | °C/W |
| Maximum Junction-to-Case | • | R _{thJC} | 0.85 | 1.1 | |

Notes:

a. Package limited.

c. $t \leq 10$ s.

b. Surface mounted on 1" x 1" FR4 board.

| Parameter | Symbol | Test Conditions | Min. | Typ.ª | Max. | Unit | |
|---|---------------------|---|--------------------|-------|-------------|------|---|
| Static | | | | | <u> </u> | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | 60 | | | V | |
| Gate Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 1 | 2 | 3 | v | |
| Gate-Body Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA | |
| | | V _{DS} = 60 V, V _{GS} = 0 V | _S = 0 V | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V_{DS} = 60 V, V_{GS} = 0 V, T_{J} = 125 °C | | | 50 | μA | |
| | | V_{DS} = 60 V, V_{GS} = 0 V, T_{J} = 175 °C | | | 250 | | |
| On-State Drain Current ^b | I _{D(on)} | V _{DS} = 5 V, V _{GS} = 10 V | 60 | | | А | |
| | | V _{GS} = 10 V, I _D = 20 A | | 0.010 | | | |
| | | V_{GS} = 10 V, I _D = 20 A, T _J = 125 °C | | 0.016 | | μA | |
| Drain-Source On-State Resistance ^b | R _{DS(on)} | V_{GS} = 10 V, I _D = 20 A, T _J = 175 °C | | 0.020 | | | Ω |
| | | V _{GS} = 4.5 V, I _D = 15 A | | 0.012 | | | |
| Forward Transconductance ^b | 9 _{fs} | V _{DS} = 15 V, I _D = 20 A | | 60 | | S | |
| Dynamic | | | - | | · · · · · · | | |
| Input Capacitance | C _{iss} | | | 2650 | | | |
| Output Capacitance | C _{oss} | V_{GS} = 0 V, V_{DS} = 25 V, f = 1 MHz | | 470 | | pF | |
| Reverse Transfer Capacitance | C _{rss} | | | 225 | | | |
| Total Gate Charge ^c | Qg | | | 47 | 70 | | |
| Gate-Source Charge ^c | Q _{gs} | V_{DS} = 30 V, V_{GS} = 10 V, I_{D} = 50 A | | 10 | | nC | |
| Gate-Drain Charge ^c | Q _{gd} | | | 12 | | | |
| Turn-On Delay Time ^c | t _{d(on)} | | | 10 | 20 | | |
| Rise Time ^c | tr | V_{DD} = 30 V, R _L = 0.6 Ω I _D \cong 50 A, V _{GEN} = 10 V, R _g = 2.5 Ω | | 15 | 25 | ns | |
| Turn-Off Delay Time ^c | t _{d(off)} | | | 35 | 50 | | |
| Fall Time ^c | t _f | | | 20 | 30 | | |
| Source-Drain Diode Ratings and Cha | aracteristics (| T _C = 25 °C) | | · | · | | |
| Pulsed Current | I _{SM} | | | | 70 | Α | |
| Diode Forward Voltage | V _{SD} | I _F = 20 A, V _{GS} = 0 V | | 1 | 1.5 | V | |
| Reverse Recovery Time | t _{rr} | I _F = 20 A, di/dt = 100 A/μs | | 45 | 100 | ns | |

Notes:

a. For design aid only; not subject to production testing.

b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

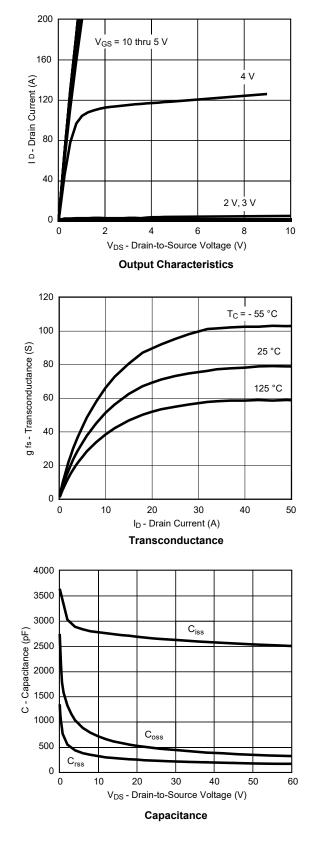
c. Independent of operating temperature.

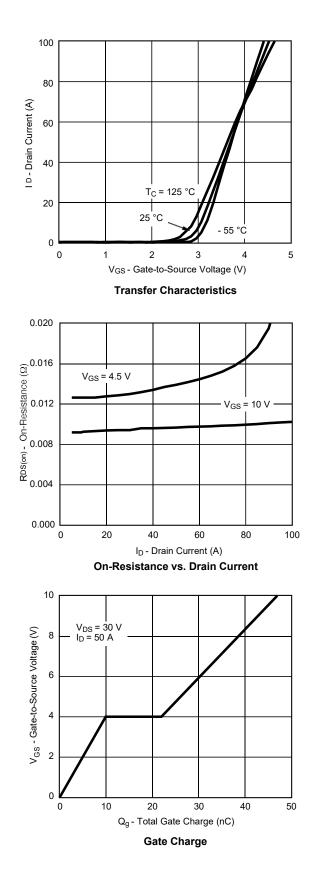
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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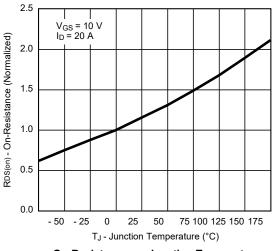
TYPICAL CHARACTERISTICS (25 °C unless noted)



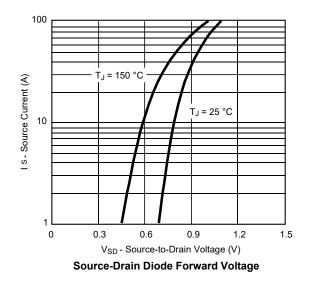




TYPICAL CHARACTERISTICS (25 °C unless noted)

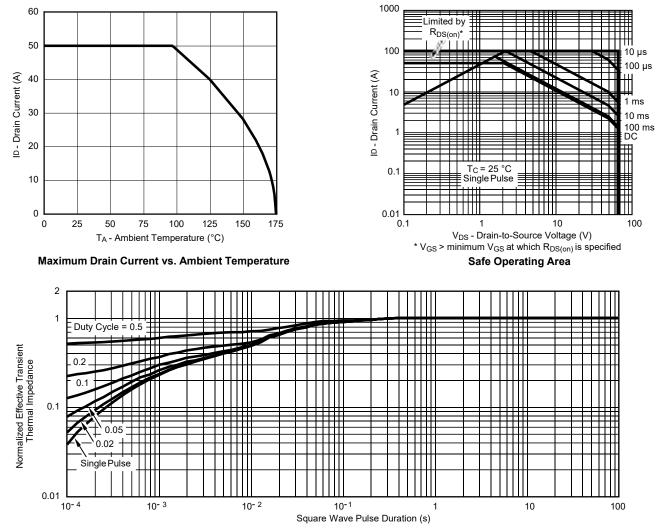


On-Resistance vs. Junction Temperature





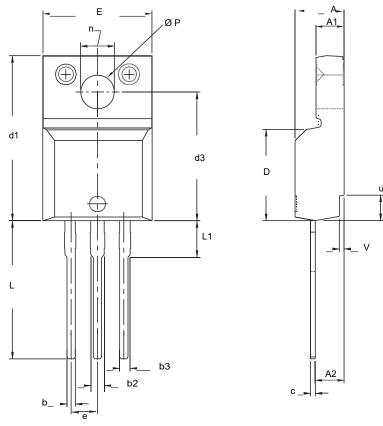
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



TO-220 FULLPAK (HIGH VOLTAGE)



| DIM. | MILL | IMETERS | INCHES | | |
|------|--------|----------|--------|-----------|--|
| | MIN. | MAX. | MIN. | MAX. | |
| А | 4.570 | 4.830 | 0.180 | 0.190 | |
| A1 | 2.570 | 2.830 | 0.101 | 0.111 | |
| A2 | 2.510 | 2.850 | 0.099 | 0.112 | |
| b | 0.622 | 0.890 | 0.024 | 0.035 | |
| b2 | 1.229 | 1.400 | 0.048 | 0.055 | |
| b3 | 1.229 | 1.400 | 0.048 | 0.055 | |
| С | 0.440 | 0.629 | 0.017 | 0.025 | |
| D | 8.650 | 9.800 | 0.341 | 0.386 | |
| d1 | 15.88 | 16.120 | 0.622 | 0.635 | |
| d3 | 12.300 | 12.920 | 0.484 | 0.509 | |
| E | 10.360 | 10.630 | 0.408 | 0.419 | |
| е | 2.5 | 2.54 BSC | | 0.100 BSC | |
| L | 13.200 | 13.730 | 0.520 | 0.541 | |
| L1 | 3.100 | 3.500 | 0.122 | 0.138 | |
| n | 6.050 | 6.150 | 0.238 | 0.242 | |
| ØР | 3.050 | 3.450 | 0.120 | 0.136 | |
| u | 2.400 | 2.500 | 0.094 | 0.098 | |
| V | 0.400 | 0.500 | 0.016 | 0.020 | |

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness. 5. No chipping or package damage.



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